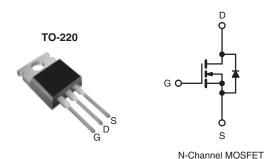


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	50			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	0.024		
Q _g (Max.) (nC)	66			
Q _{gs} (nC)	21			
Q _{gd} (nC)	25			
Configuration	Single			



FEATURES

- · Dynamic dV/dt Rating
- 175 °C Operating Temperature
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Lead (Pb)-free Available





DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220		
Lead (Pb)-free	IRFZ46PbF		
Lead (FD)-liee	SiHFZ46-E3		
SnPb	IRFZ46		
	SiHFZ46		

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	50	.,	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Currente	V _{GS} at 10 V	T _C = 25 °C	I _D	50	А	
Continuous Drain Current		T _C = 100 °C		38		
Pulsed Drain Current ^a			I _{DM}	220	1	
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	100	mJ	
Maximum Power Dissipation	T _C = 25 °C		P_{D}	150	W	
Peak Diode Recovery dV/dtc			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature) ^d	for 10 s			300]	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. V_{DD} = 25 V, starting T_J = 25 °C, L = 34 μ H, R_G = 25 Ω , I_{AS} = 54 A (see fig. 12). c. I_{SD} \leq 54 A, dl/dt \leq 250 A/ μ s, V_{DD} \leq V_{DS} , T_J \leq 175 °C. d. 1.6 mm from case

- e. Current limited by the package, (die current = 54 A).

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	62	
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0	

SPECIFICATIONS T _J = 25 °C,	unless otherv	vise noted					
PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		50	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	o 25 °C, I _D = 1 mA	-	0.057	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{C}$	_{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	Vo	V _{GS} = ± 20		-	± 100	nA
Zana Cata Waltana Busin Comment		V _{DS} = 5	V _{DS} = 50 V, V _{GS} = 0 V		-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 48 V, V ₀	_{GS} = 0 V, T _J = 150 °C	-	-	250	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 32 A ^b	-	-	0.024	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 2	5 V, I _D = 32 A ^b	27	-	-	S
Dynamic							
Input Capacitance	C _{iss}	V	0 V	-	1800	-	
Output Capacitance	C _{oss}	V	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		960	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	160	-	
Total Gate Charge	Qg			-	-	66	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 54 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13 ^b	-	-	21	
Gate-Drain Charge	Q _{gd}		See lig. o and 13"	-	-	25	
Turn-On Delay Time	t _{d(on)}			-	12	-	
Rise Time	t _r	V_{DD} = 28 V, I_{D} = 54 A, R_{G} = 9.1 Ω, R_{D} = 0.49 Ω, see fig. 10 ^b		-	120	-	ns
Turn-Off Delay Time	t _{d(off)}			-	42	-	
Fall Time	t _f			-	95	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s					<u>'</u>	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	50°	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	220	
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = 54 A, V _{GS} = 0 V ^b		-	-	2.5	٧
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 54 A, dl/dt = 100 A/μs ^b		-	66	99	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.17	0.31	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)					L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.
- c. Current limited by the package, (die current = 54 A).



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

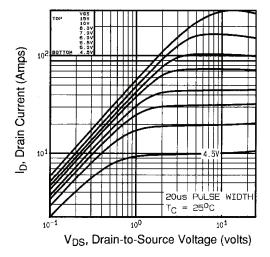


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

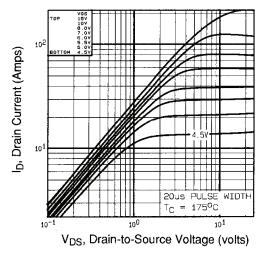


Fig. 2 - Typical Output Characteristics, $T_C = 175$ °C

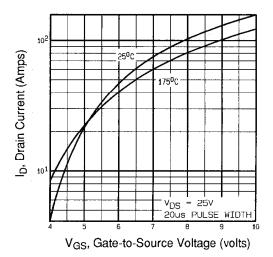


Fig. 3 - Typical Transfer Characteristics

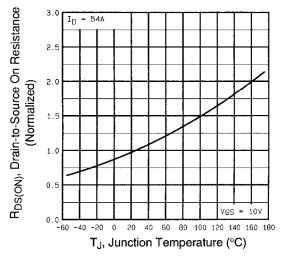


Fig. 4 - Normalized On-Resistance vs. Temperature



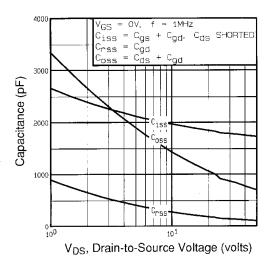


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

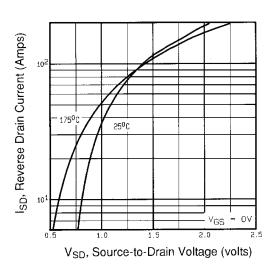


Fig. 7 - Typical Source-Drain Diode Forward Voltage

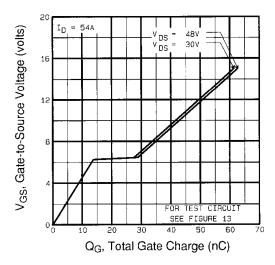


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

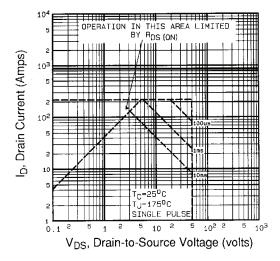


Fig. 8 - Maximum Safe Operating Area



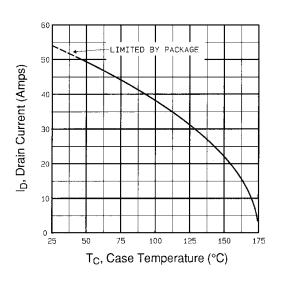


Fig. 9 - Maximum Drain Current vs. Case Temperature

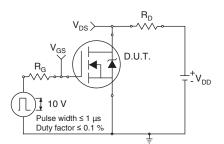


Fig. 10a - Switching Time Test Circuit

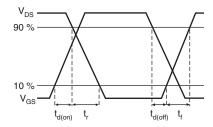


Fig. 10b - Switching Time Waveforms

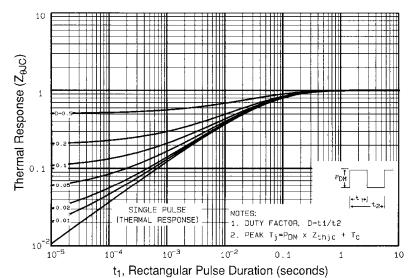


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

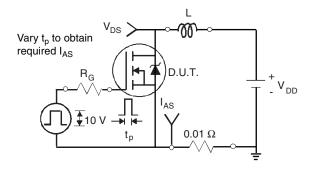


Fig. 12a - Unclamped Inductive Test Circuit

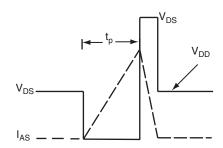


Fig. 12b - Unclamped Inductive Waveforms



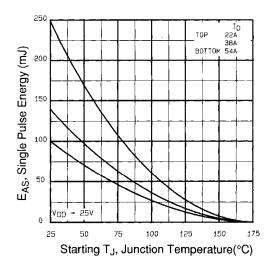


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

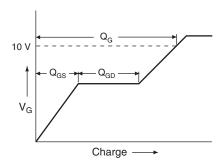


Fig. 13a - Basic Gate Charge Waveform

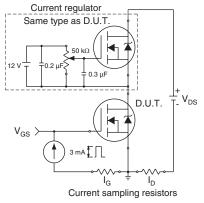
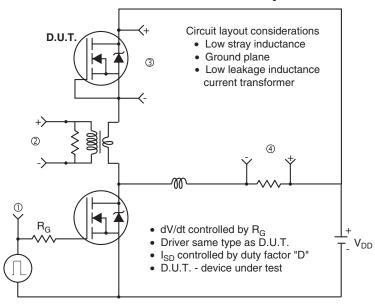


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



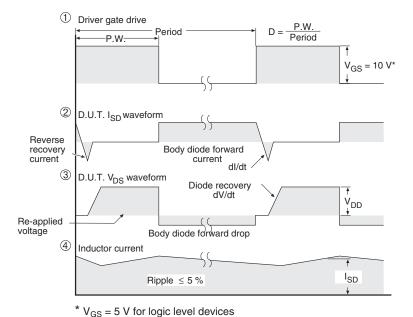


Fig. 14 - For N-Channel

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